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FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Attorney Docket No.: W&B-INF-860 Appl. No. 09/977 787 Applicant UDO HARTMANN			
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Filing Date October 15, 2001 Group Art Unit 2133			
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EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
THE	Α	6,195,771 B1	02/01	Tanabe et al.	€		
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FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
THE	J	EP 0 828 257 A2	03/98	Europe	-	}	
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OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
M		Tadahiko Sugibayashi et al.: "A Distributive Serial Multi-Bit Parallel Test Scheme for Large Capacity DRAMs", IEICE Trans. Electron., Vol. E77-C, No. 8, August 1994, pp. 1323-1327;					
EXAMINER	lun	James	,	DATE CONSIDERE	D 104		
EXAMINER: Initially citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							